

Control-Quality Optimization for Distributed Embedded Systems with Adaptive Fault Tolerance

Soheil Samii^{1,2}, Unmesh D. Bordoloi², Petru Eles²,
Zebo Peng², Anton Cervin³

¹Embedded Intelligent Solutions, Semcon AB

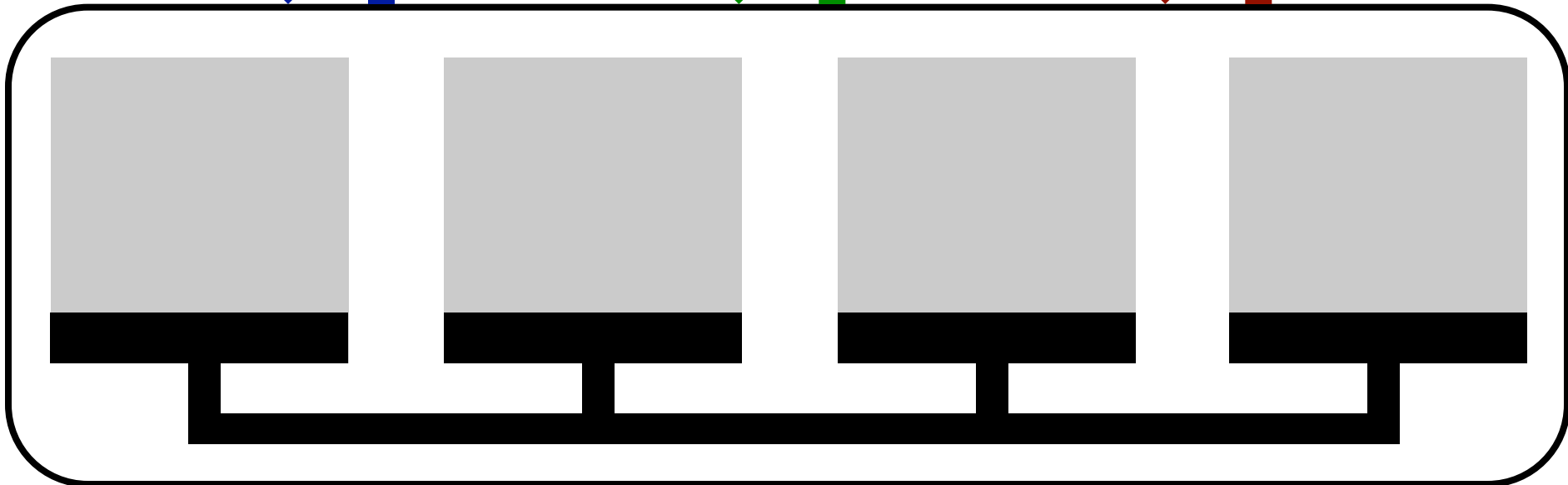
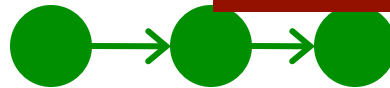
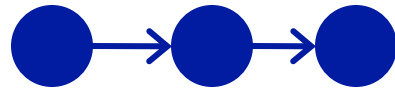
²Dept. of Computer and Information Science, Linköping University

³Dept. of Automatic Control, Lund University

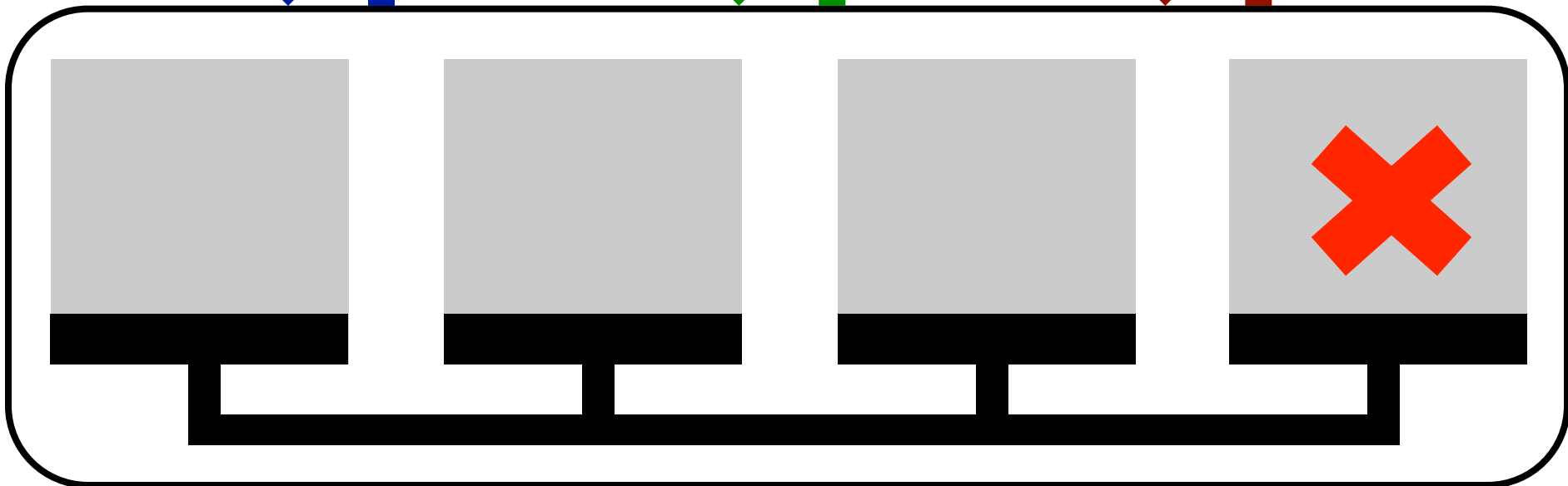
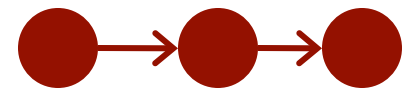
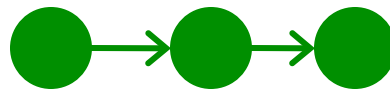
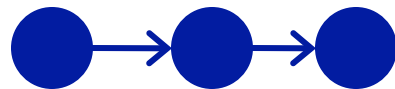
Sweden

Motivation

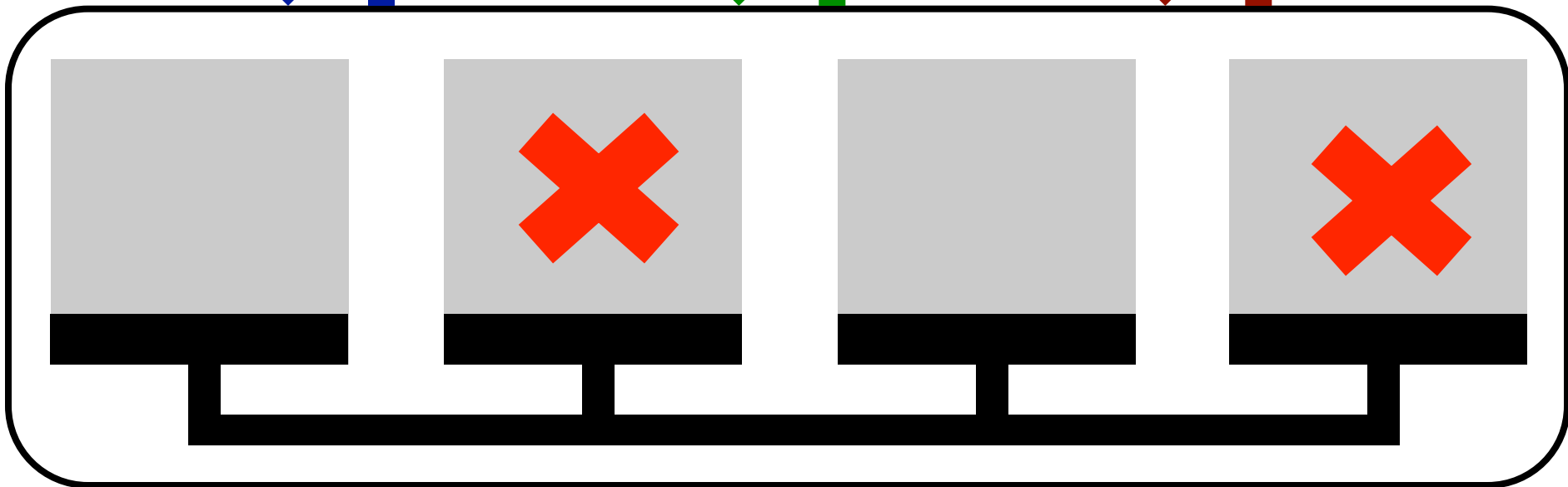
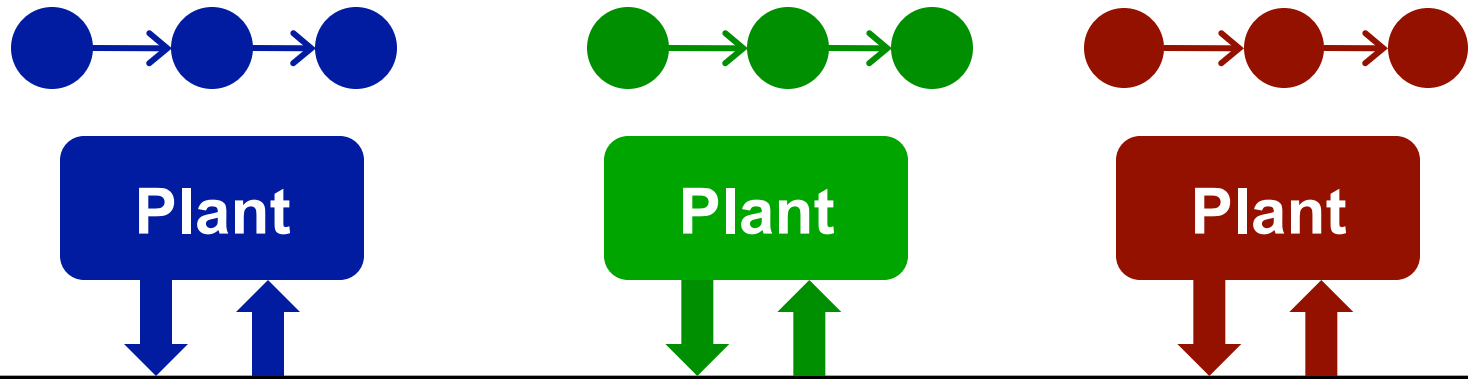
- **Control quality**
 - **Periods, control laws**
 - **Mapping, schedule**



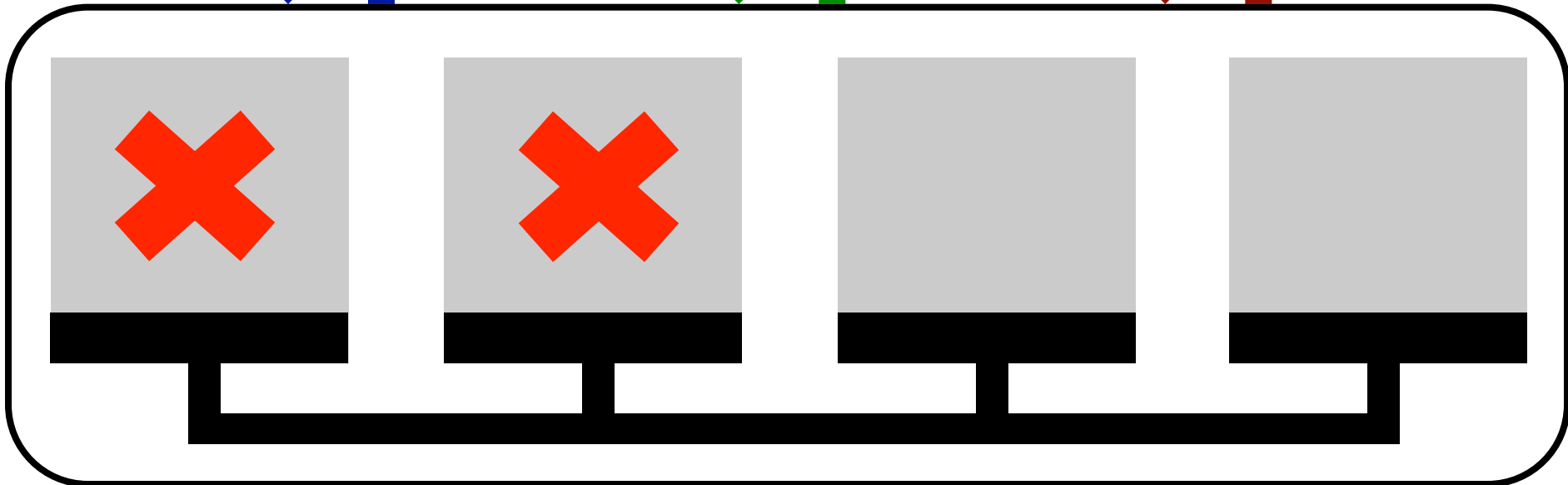
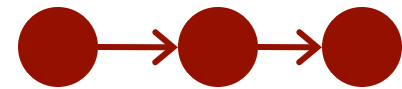
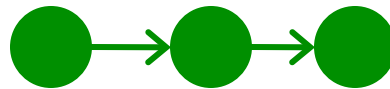
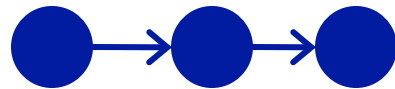
Motivation



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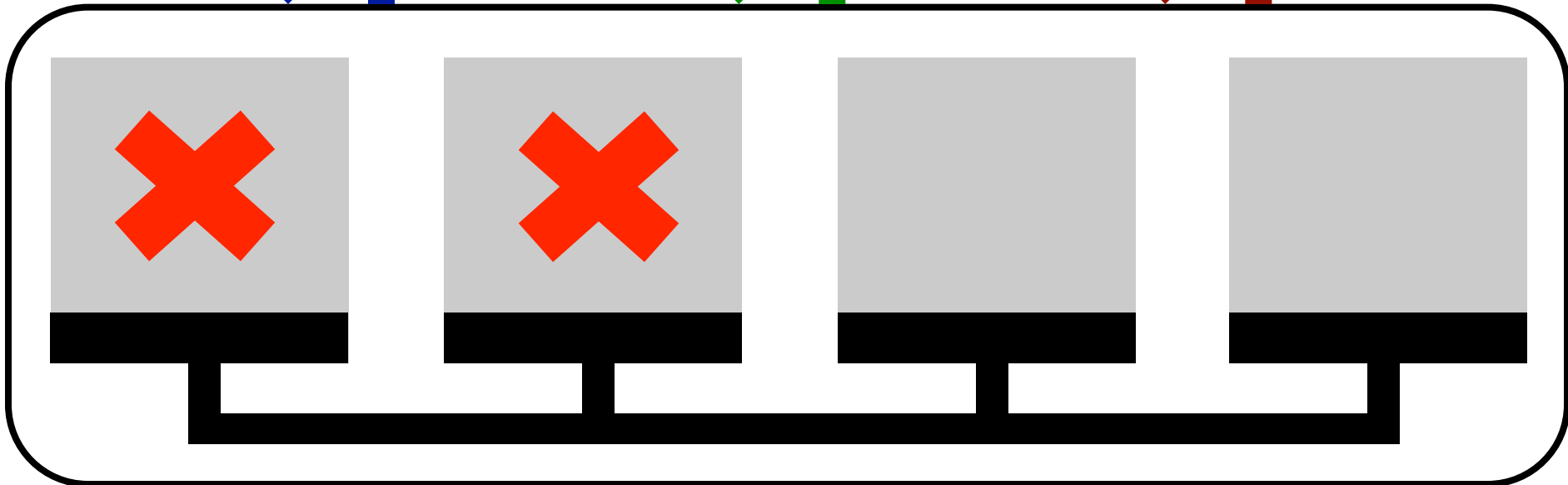
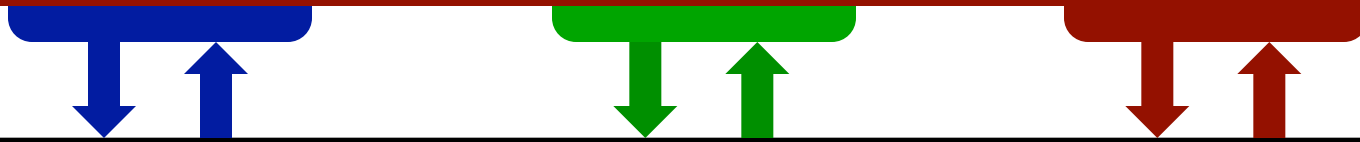


Motivation



Motivation

- Node faults lead to new configurations
- Unpractical to synthesize solutions for all configurations



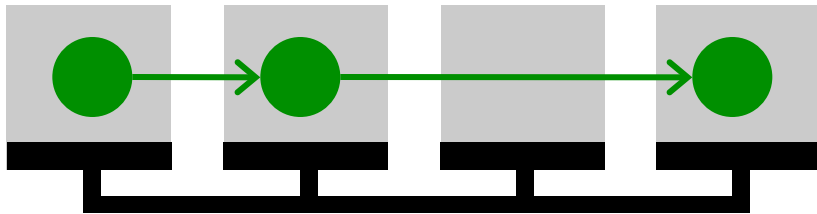
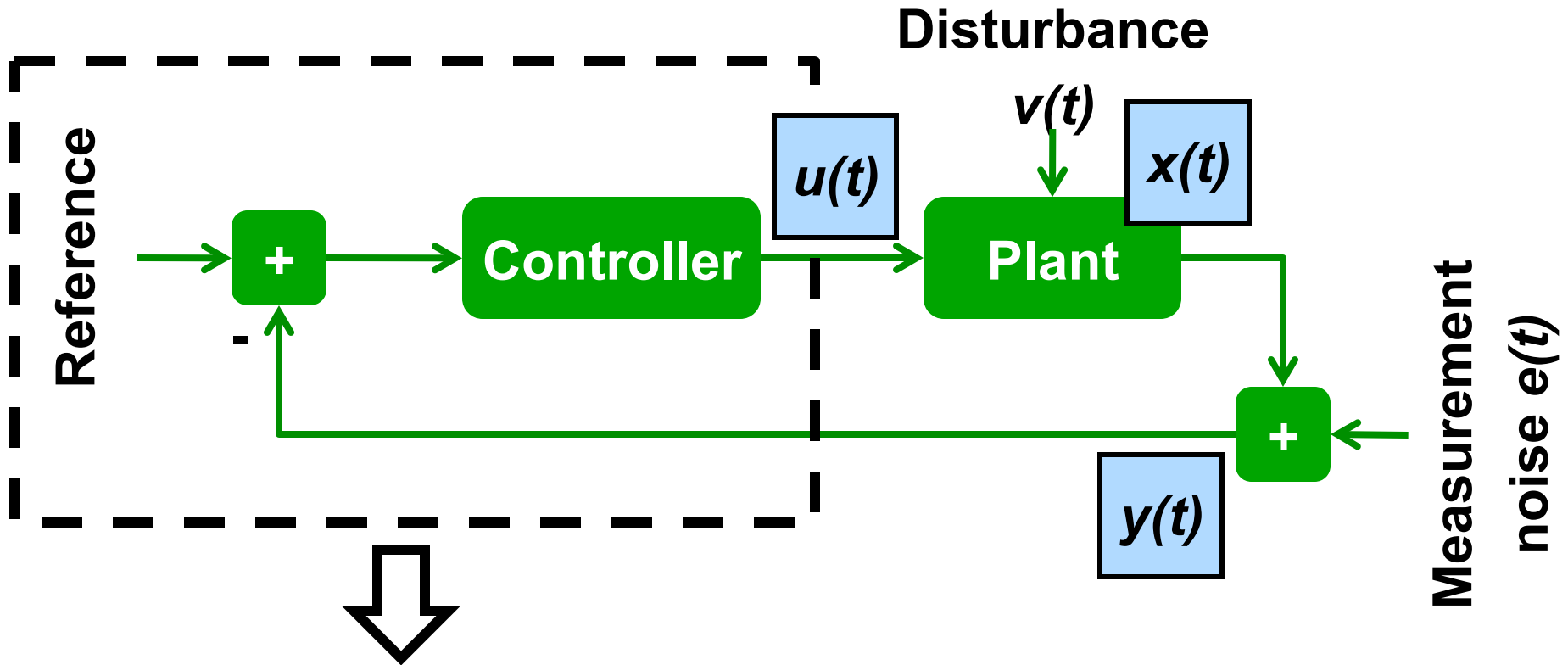
Overview of our approach

- **Classify feasible configurations**
 - **Sufficient computation capacity**
 - **Availability of external interfaces to sensors and actuators**
- **Synthesis of a certain set of base configurations is sufficient to satisfy fault-tolerance requirements**
- **Design optimization for additional configurations to optimize control quality**

Outline

- **System model**
- **Example: Distributed control systems with faults**
- **Base configurations**
- **Control-quality optimization**
- **Experiments**

System model

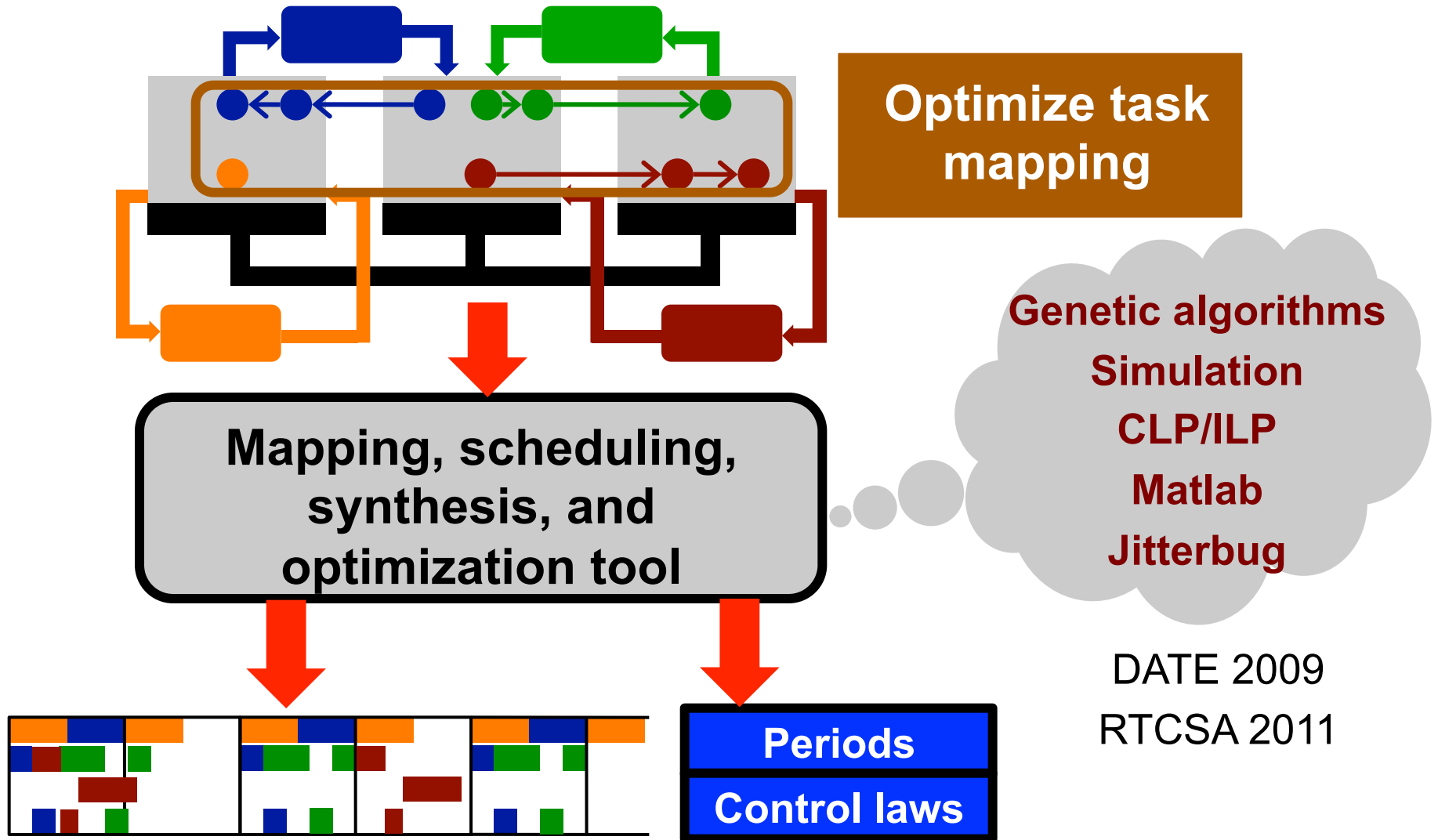


$$\begin{aligned} \frac{dx(t)}{dt} &= Ax(t) + Bu(t) + v(t) \\ y(t) &= Cx(t) + e(t) \end{aligned}$$

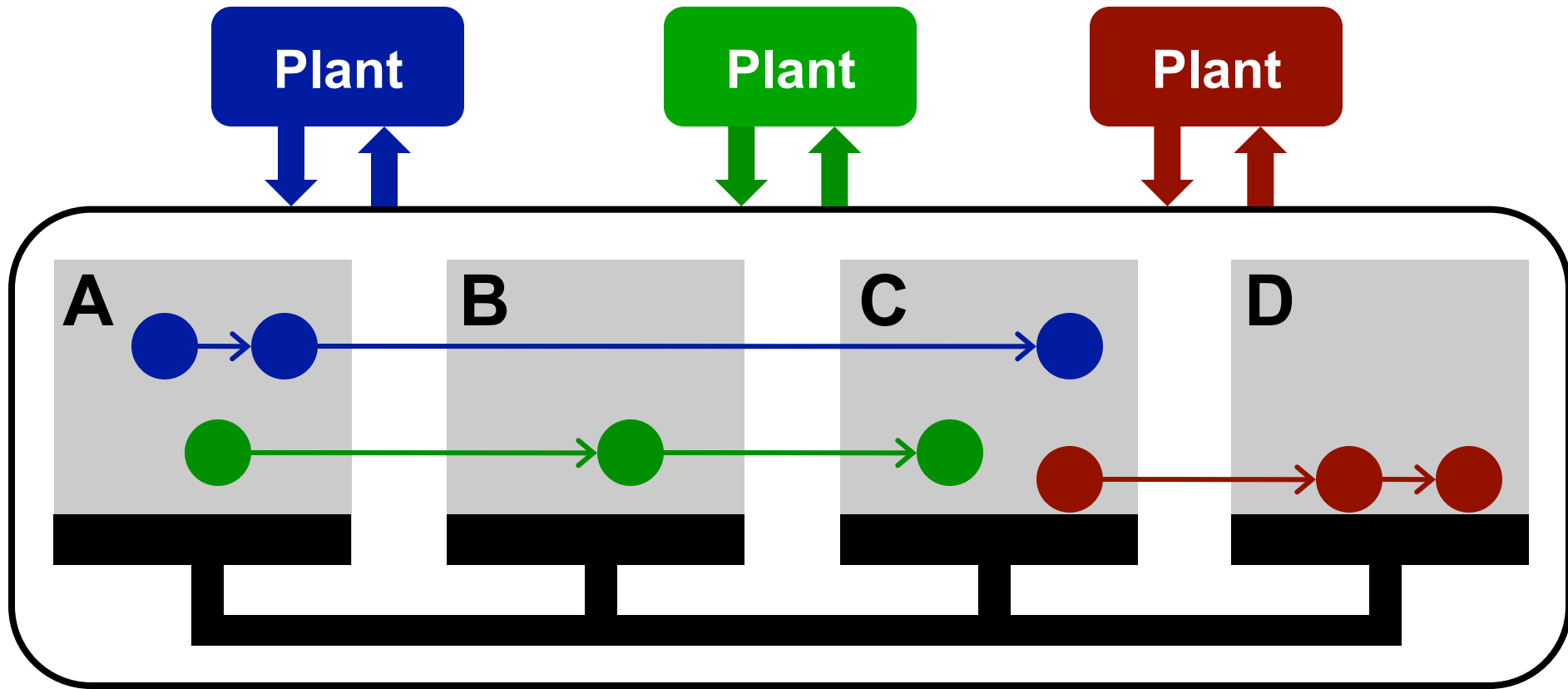
Control quality

- **Quadratic cost: $J = E\{ \mathbf{x}^T \mathbf{Q}_1 \mathbf{x} + \mathbf{u}^T \mathbf{Q}_2 \mathbf{u} \}$**
- **Depends on**
 - **the sampling period,**
 - **the control law, and**
 - **the mapping and schedule (delays between sampling and actuation)**
- **”Jitterbug” (Lund University)**

Co-Design Tool for Distributed Control

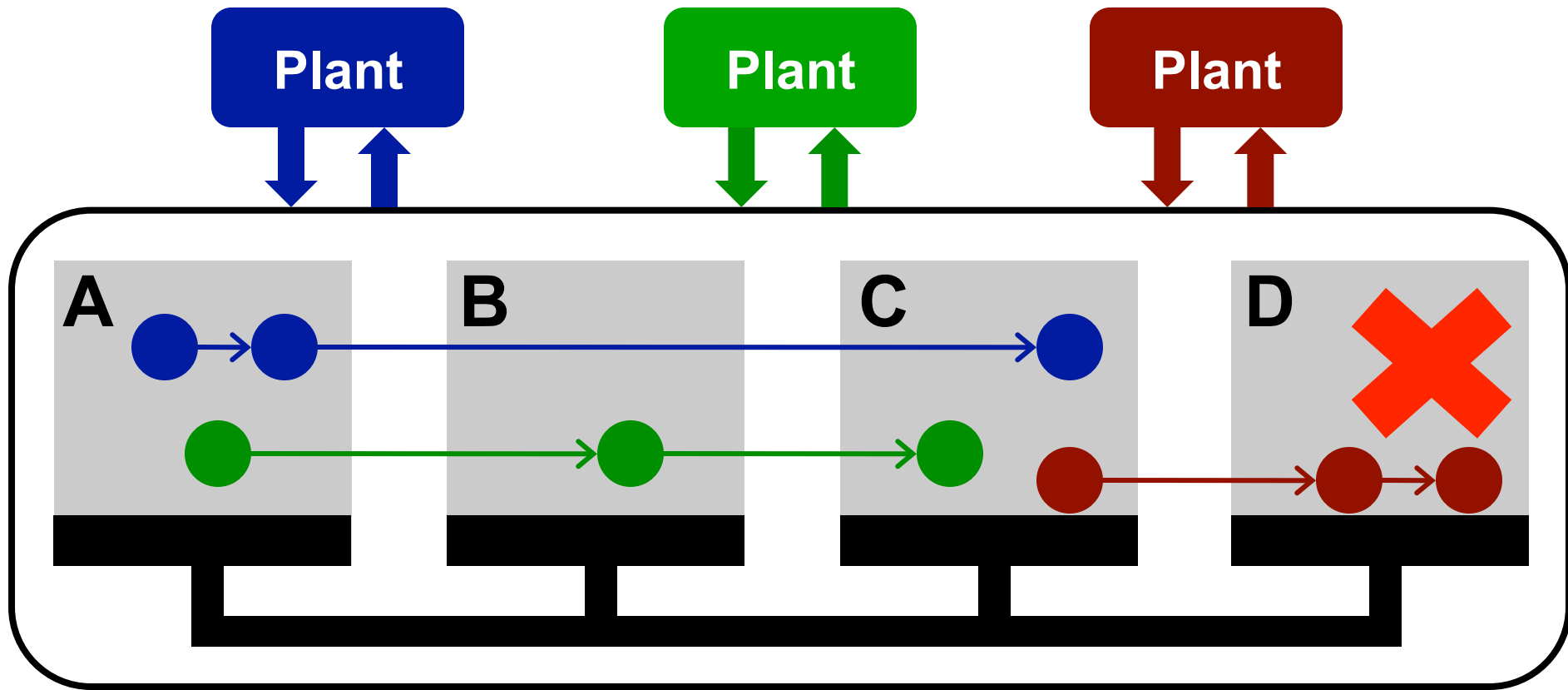


Example



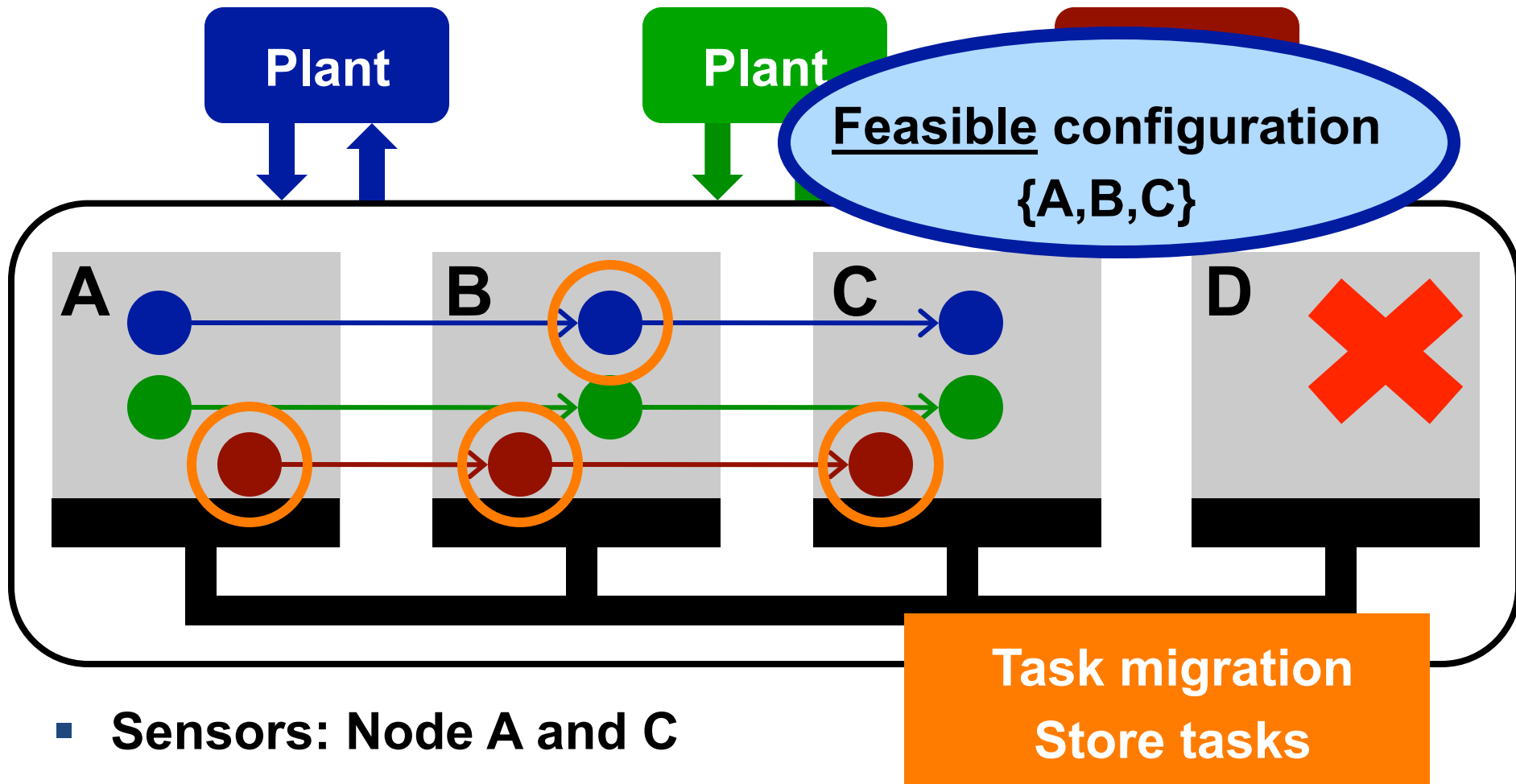
- **Sensors: Node A and C**
- **Actuators: Node C and D**

Configurations



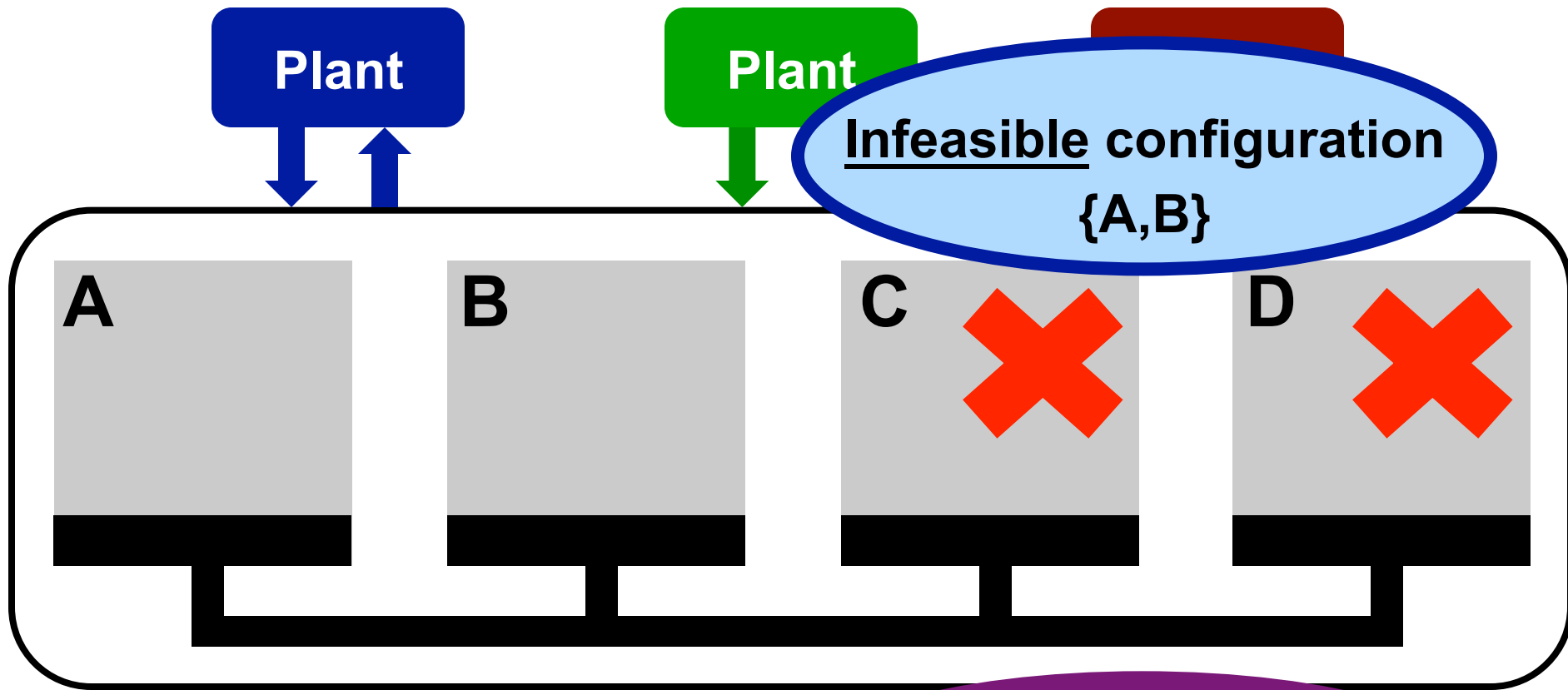
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Configurations



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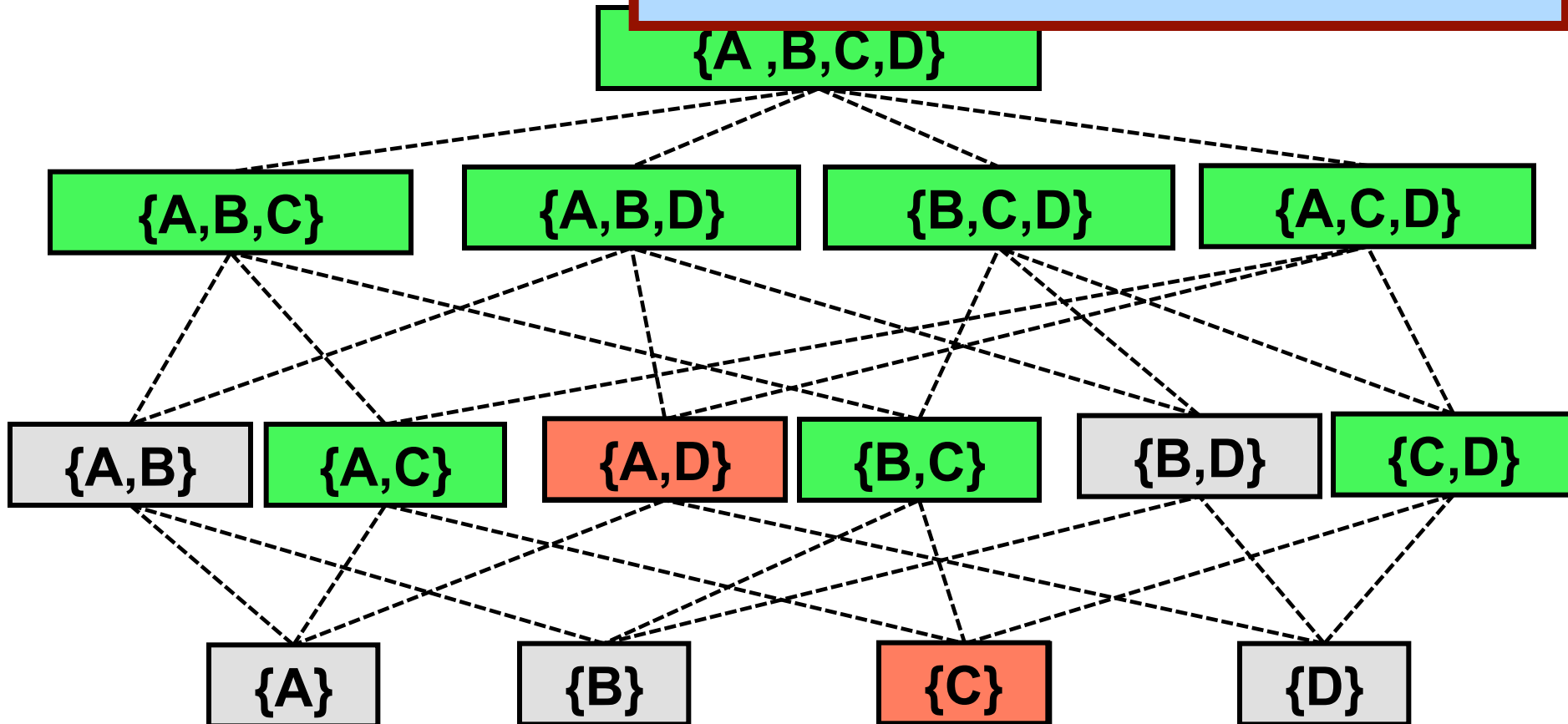


- **Sensors: Node A and C**
- **Actuators: Node C and D**

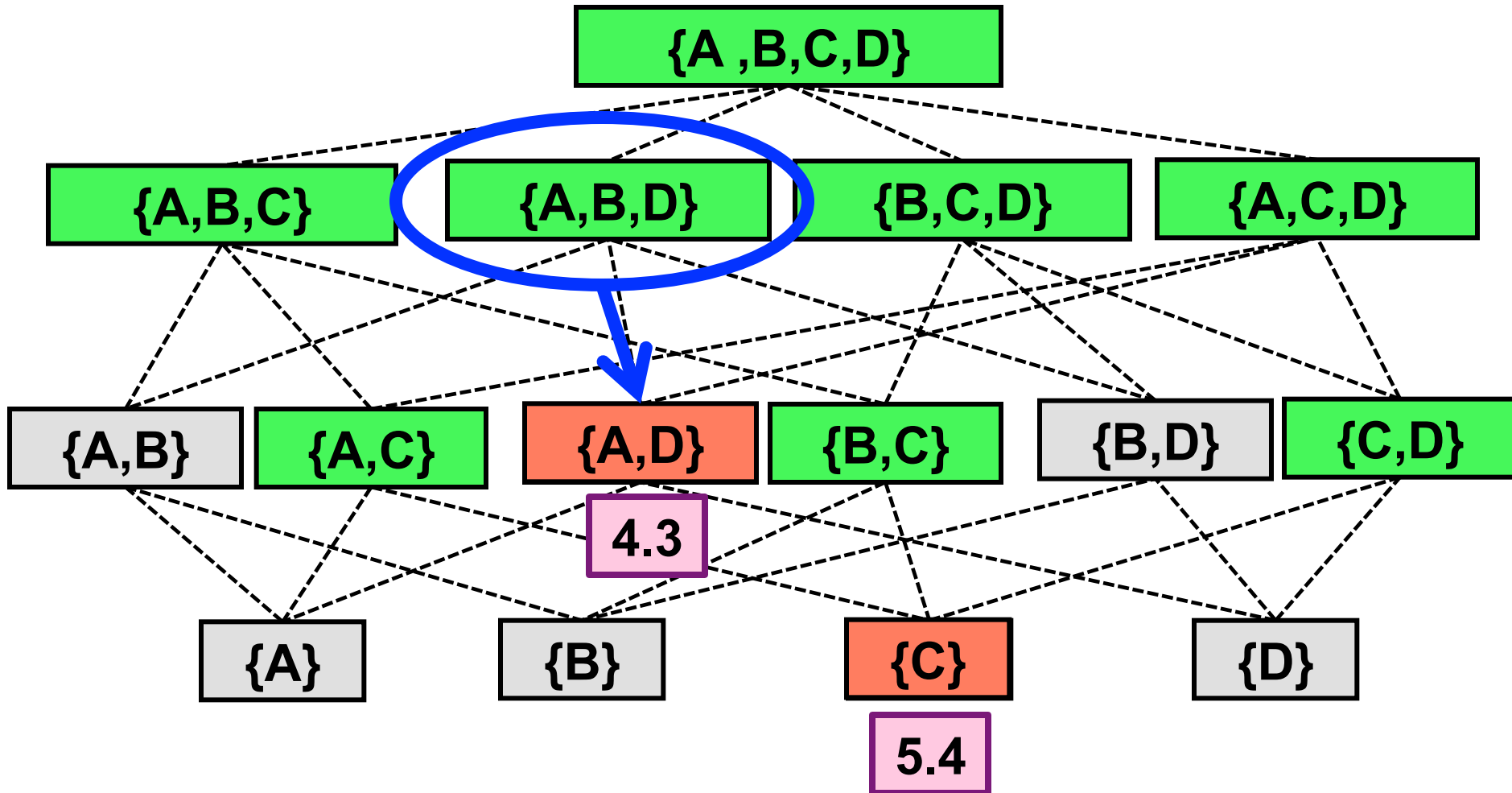
Actuation cannot be done!

Configurations

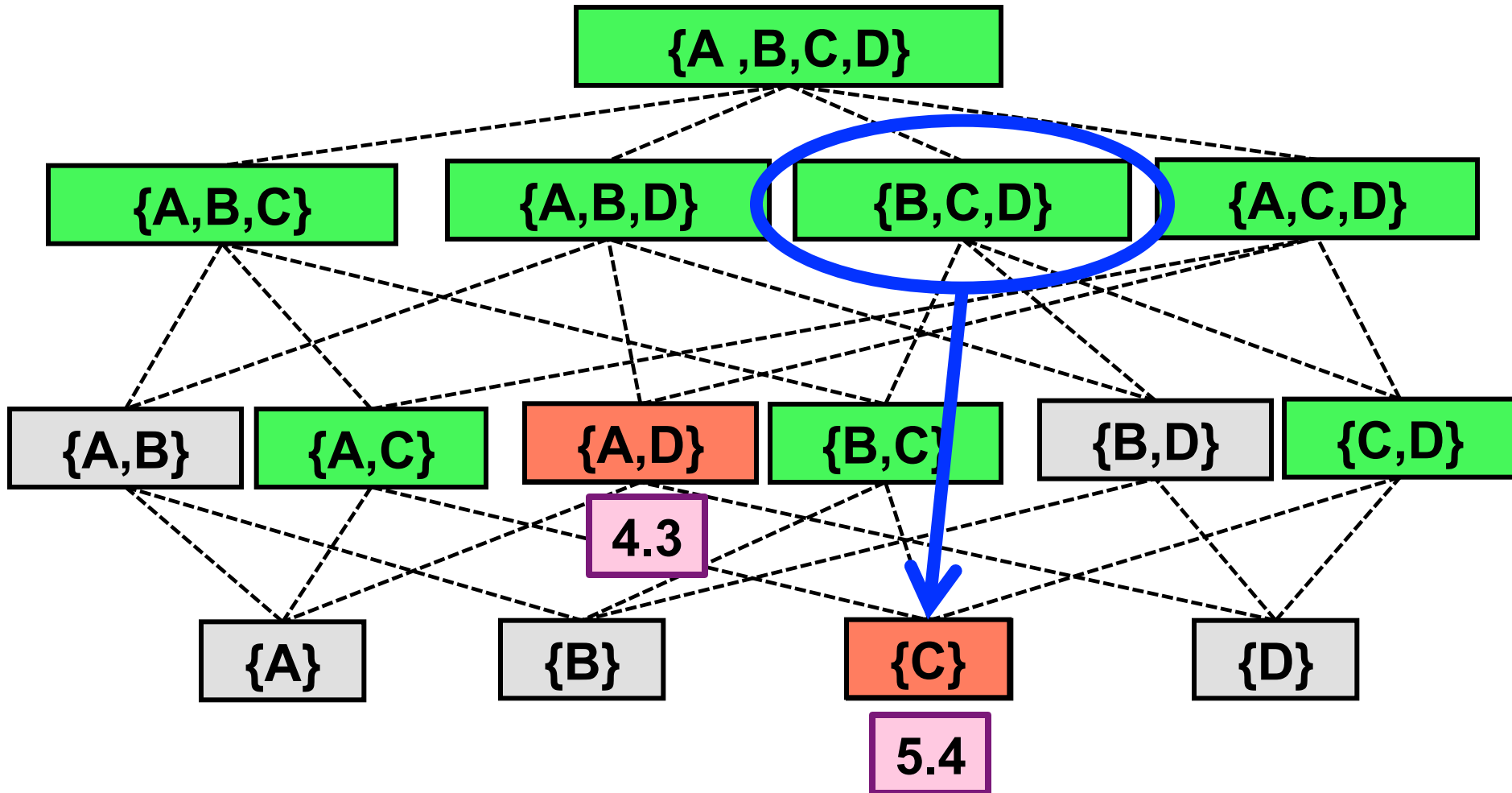
- Synthesize mapping, schedule, and control laws for each base configuration



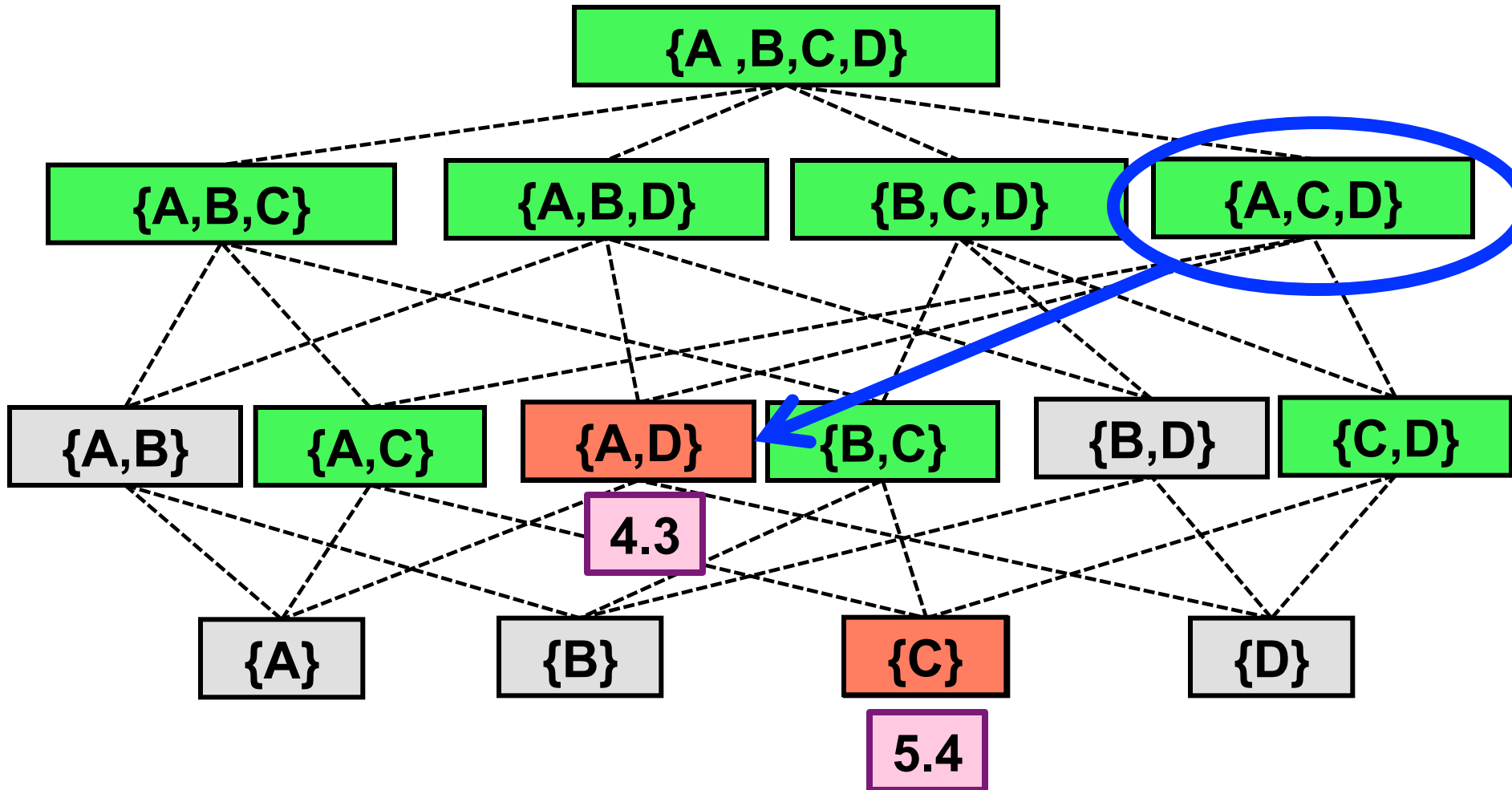
Configurations



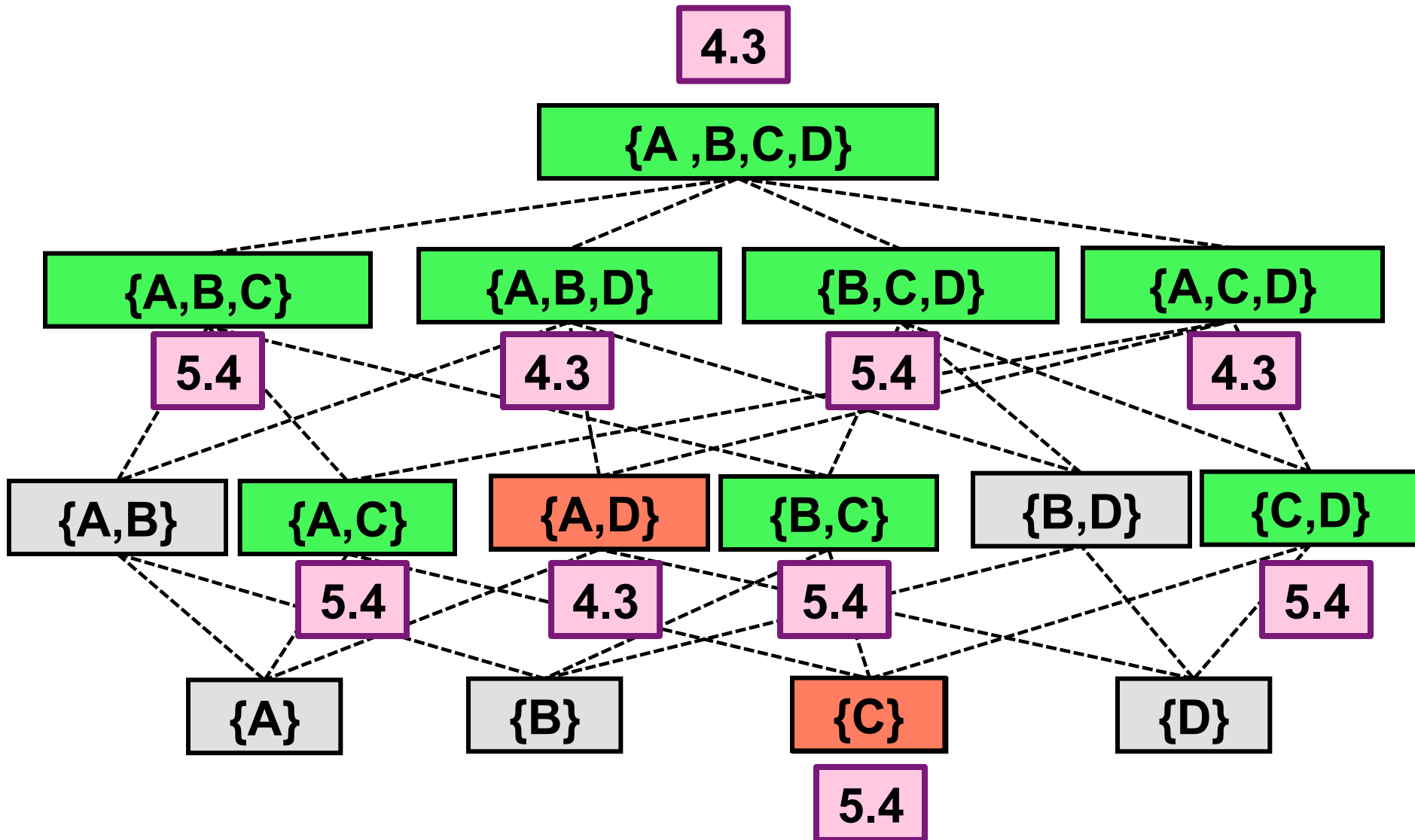
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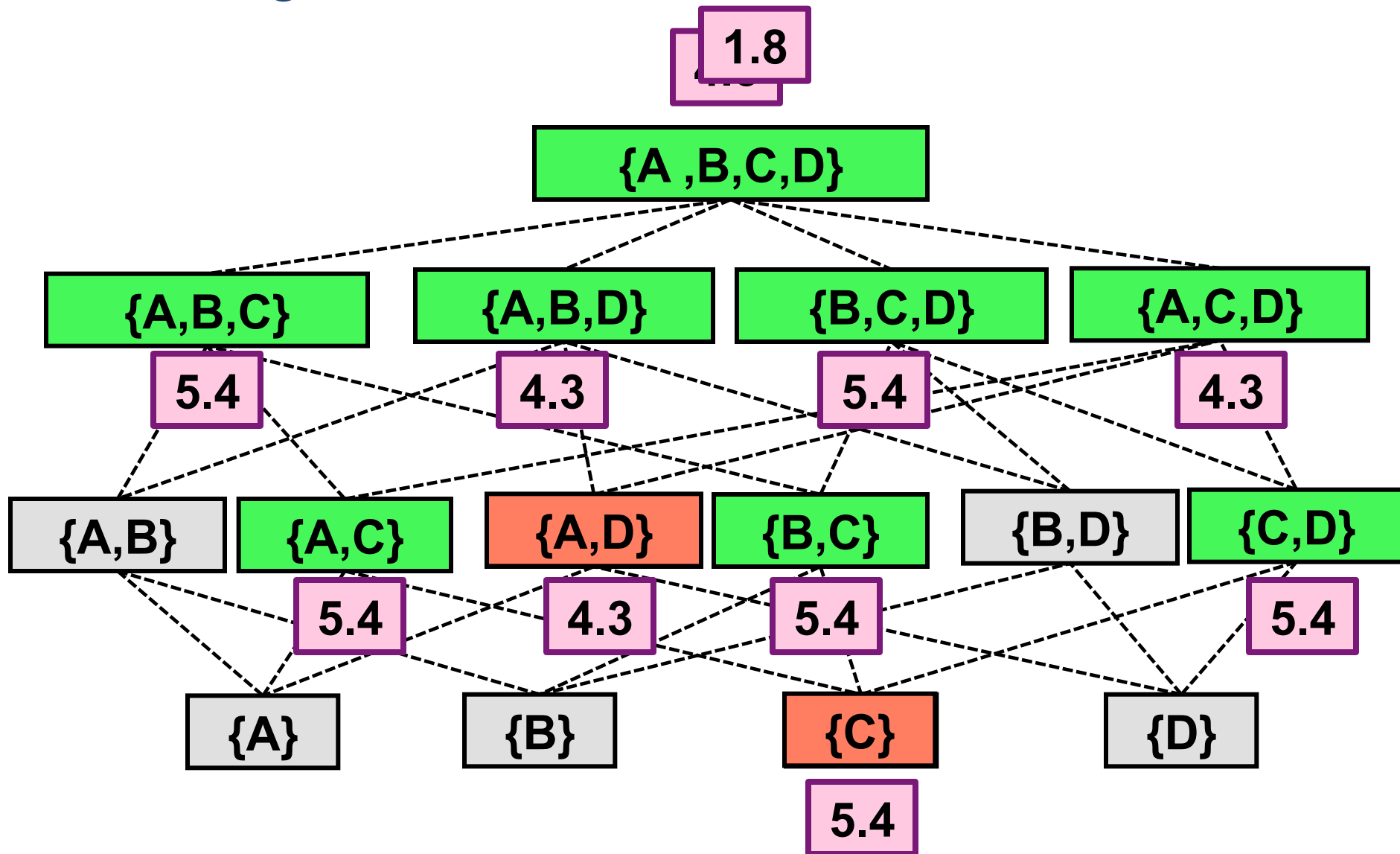
Configurations



Configurations



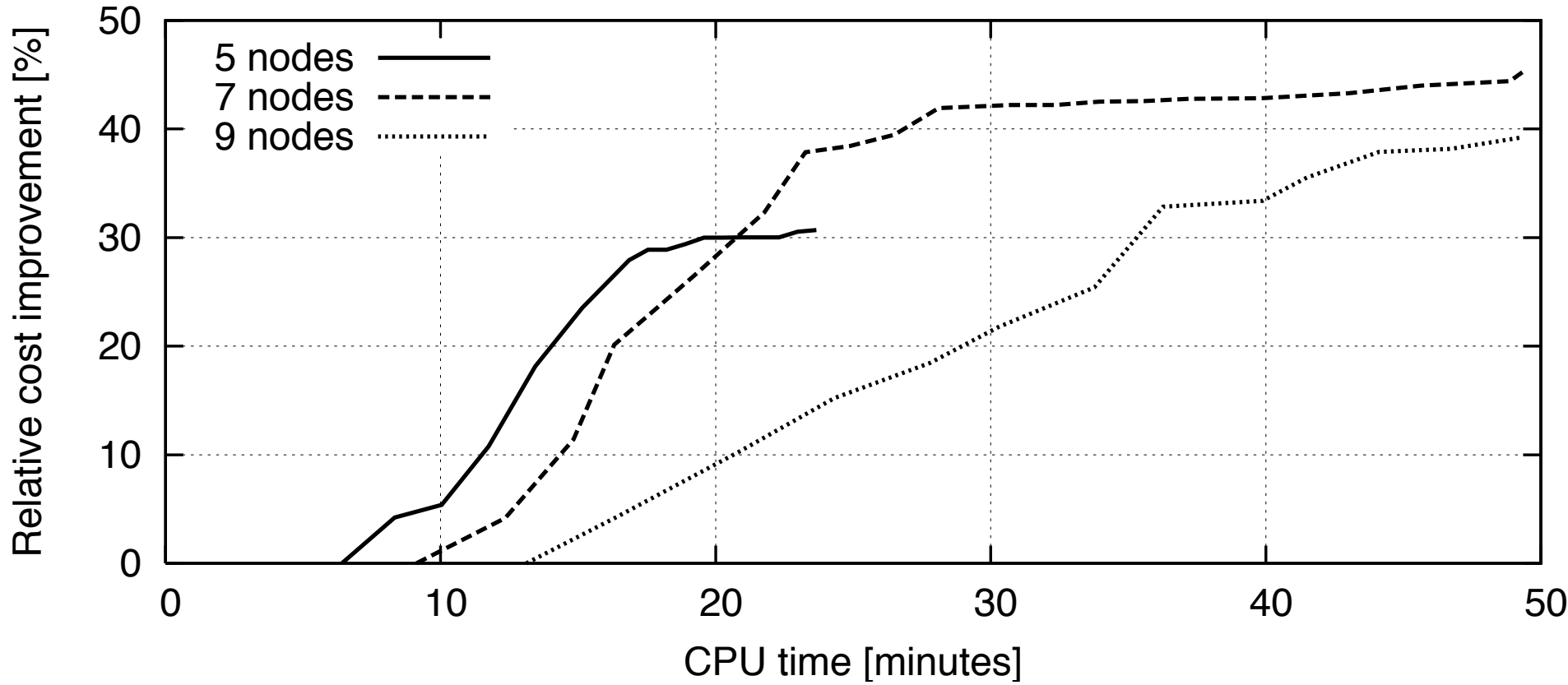
Configurations



Optimization

- **Construct solutions for additional configurations (heuristic considers node failure probabilities)**
 - **Trade-offs: control quality, design time**
- **Mapping realization (ILP formulation)**
 - **Task migration (time constraint, overhead)**
 - **Store tasks on nodes (memory constraint)**
- **Cost function to minimize:** $\sum_C p_C \cdot J_C$
 - **p_C : Probability of reaching configuration C**

Experiments



Conclusions

- **Faults lead to different configurations**
 - **Not practical to design a customized solution to each configuration**
- **Synthesize solutions to a subset of all configurations in order to achieve a level of fault tolerance given by the available sensor/actuator interfaces and capacity of the platform**
- **Optimization method for control-quality improvements in the configurations**